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Application No. <u>10105,663</u>	Prepared by <u>NH</u>	Tracking Number <u>05918987</u>	
Examiner-GAU <u>Vargot-1732</u>	Date <u>4-13-4</u>	Week Date <u>03/15/04</u>	
	No. of queries <u>1</u>	IFW	

JACKET			
a. Serial No.	f. Foreign Priority	k. Print Claim(s)	<u>q. PTO-1449</u>
b. Applicant(s)	g. Disclaimer	l. Print Fig.	q. PTOL-85b
c. Continuing Data	h. Microfiche Appendix	m. Searched Column	r. Abstract
d. PCT	i. Title	n. PTO-270/328	s. Sheets/Figs
e. Domestic Priority	j. Claims Allowed	o. PTO-892	t. Other

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FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.
BIF114531SERIAL NO.
10/015,586**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**

(Use several sheets if necessary)

APPLICANT
Hao-Wen Chiu et al.FILING DATE
December 17, 2001GROUP
1722 1732

37 CFR 1.98(b)

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		PATENT NUMBER	ISSUE DATE	PATENTEE	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
W-DU	AA	5,376,317	12/94	MAUS et al.			
W-DU	AB	5,458,820	10/95	LEFEBVE			
	AC						
	AD						

FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION

		DOCUMENT NO.	PUBL. DATE	COUNTRY OR PATENT OFFICE	CLASS	SUB CLASS	TRANSLATION YES NO
W-DU	AI	99/24243	05/99	WO			
W-DU	AJ	2 525 525	10/83	FR			English abstract
	AK						
	AL						
	AM						
	AN						
	AO						
	AP						
	AQ						

OTHER DOCUMENTS (Including Author, Title, Date, Relevant Pages, Place of Publication)

	AT	
	AU	
	AV	
	AX	
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EXAMINER

M. Vargot

DATE CONSIDERED

5/24/04

EXAMINER: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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